

| | | | |
|-----------------------------------|---------------------------------------|--|-------------|
| Notice of References Cited | Application/Control No. 10/007,620 | Applicant(s)/Patent Under Reexamination BRUMMEL ET AL. | |
| | Examiner X. L. Bautista | Art Unit 2179 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|---------------------|----------------|
| * | A | US-2002/0022973 A1 | 02-2002 | Sun et al. | 705/3 |
| * | B | US-7,038,588 B2 | 05-2006 | Boone et al. | 340/573.1 |
| * | C | US-2002/0010679 A1 | 01-2002 | Felsher, David Paul | 705/51 |
| * | D | US-7,022,075 B2 | 04-2006 | Grunwald et al. | 600/446 |
| * | E | US-2002/0116226 A1 | 08-2002 | Auer et al. | 705/3 |
| * | F | US-5,115,501 | 05-1992 | Kerr, Linda L. | 707/9 |
| * | G | US-5,495,567 | 02-1996 | Iizawa et al. | 715/762 |
| * | H | US-5,535,321 | 07-1996 | Massaro et al. | 715/707 |
| * | I | US-5,394,521 | 02-1995 | Henderson et al. | 715/804 |
| * | J | US-5,874,958 | 02-1999 | Ludolph, Frank | 715/781 |
| * | K | US-5,745,096 | 04-1998 | Ludolph et al. | 715/764 |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.